Search Notes



Application/Control No.	Applicant(s)/Patent un Reexamination	der
10/815,483	TRIMBERGER ET AL	
Examiner	Art Unit	
Phallaka Kik	2825	

	SEAR	CHED	
Class	Subclass	Date	Examiner
716	4,16,18	9/2/2006	PK
714	32,33,725	9/2/2006	PK
714	742	9/2/2006	PK
324	528, 537	9/2/2006	PK
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IN1	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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SEARCH NOT (INCLUDING SEARCH		)
	DATE	EXMR
BRS (EAST)USPAT, USPGPUB Cls/sub searched: 716/1-18; 714/32-46, 724-742; 324/527-528, 537 (see attached)	9/2/2006	PK
EPO, JPO, IBM TDB, Derwent (see attached)	9/2/2006	PK
IEE/IEEE Xplore (see attached)	9/2/2006	PK